

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10560907	SUGIHARA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Kim, Jay C	2815

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
257	43, 613, E21.372, E29.273, E27.06, E29.169, E29.242, E29.273, E21.051, E21.4, E21.372	10/30/07	J.K.

<b>SEARCH NOTES</b>			
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>	
EAST (DERWENT), See EAST Search History	10/29/07	J.K.	
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	10/29/07	J.K.	
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	10/30/07	J.K.	
EAST (DERWENT), See EAST Search History	11/5/07	J.K.	
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	11/5/07	J.K.	
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	11/12/07	J.K.	
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	11/13/07	J.K.	

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>